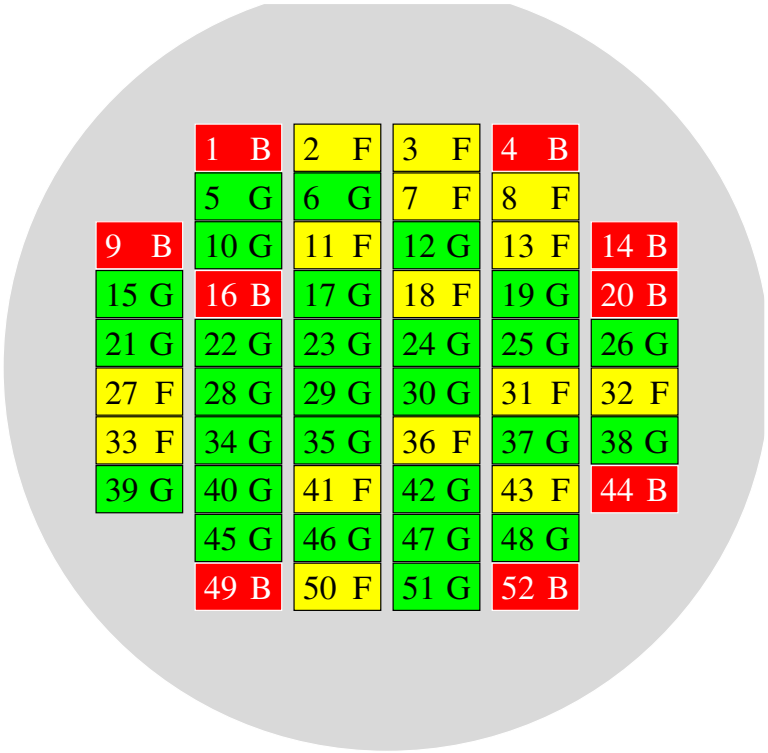
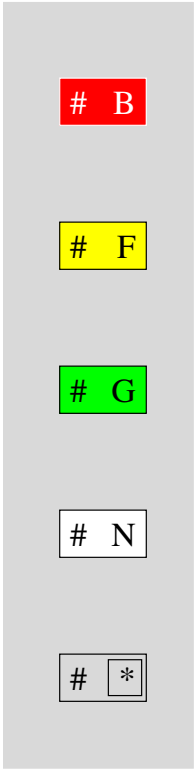
Die quality map for wafer 23 s/n: 21316-06-05

Date: 01/05/99





Bad die

Fair die

Good die

No info

Manually tagged